

Notice of References Cited	Application/Control No. 10/699,135	Applicant(s)/Patent Under Reexamination TOHSCHÉ, ULF	
	Examiner Hiep Nguyen	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,232,810	05-2001	Oklobdzija et al.	327/217
	B	US-6,445,217	09-2002	Kojima et al.	327/57
	C	US-6,720,813	04-2004	Yee et al.	327/218
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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